Non-stop CNC Vision Measuring System with Tracking Auto Focus (TAF) Quick Vision QV STREAM PLUS



Captures images and tracks surfaces while in motion providing unsurpassed throughput

Vision Measuring Systems





Non-stop CNC Vision Measuring System with Tracking Auto Focus (TAF) **Quick Vision QV STREAM PLUS**



FEATURES

- Enables high-throughput measurement—more than five times higher than earlier models. *Using Mitutoyo sample workpieces
- New method captures the image continuously without stopping the stage.
- Includes a tracking auto focus (TAF) feature that tracks the contours of waves and warpage on the surface of the workpiece and maintains focus. This eliminates time spent for autofocusing.

SPECIFICATIONS

Specifications for QV STREAM PLUS Series systems with TAF

Order No.		363-176	363-186	363-196				
Model		QV-X302T1S-D	QV-X404T1S-D	QV-X606T1S-D				
Main unit								
Measuring range (X×Y×Z)		11.81"x7.87"x7.87" (300×200×200mm)	15.57 "x15.57 "x9.84" (400×400×250mm)	23.62"x25.59"x9.84"(600×650×250mm)				
Performance								
Accuracy E1	X, Y axes (image)	(1.5+3L/1000) µm *1						
	Z axis (image)	(1.5+4L/1000) µm * ¹						
Accuracy E2	XY plane (image)	(2+4L/1000) µm *1						
Resolution		0.1µm						
TAF Z-axis resolution		0.3µm						
Operating temperature range		20±1°C						
Main equipme	nt and features							
Imaging Device		B&W CCD						
Illumination Unit	Co-axial Light	Color LED						
	Transmitted Light	Blue LED						
	PRL	Color LED (quadrant)						
Observation unit		PPT 1X-2X-6X						

^{*1} Determined using Mitutoyo inspection methods. Optical magnification for which accuracy guaranteed: 2.5X objective (QV-HR2.5X or QV-SL2.5) + 2X tube lens

Tracking Auto Focus (TAF)

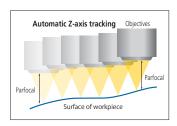
The TAF feature focuses continuously, adjusting to changes in the height of the object being measured. Automatic tracking of surface waves and warpage (in the Z axis height direction) improves measurement throughput. The feature also cuts out the hassle of focusing during manual measurement, reducing the work burden for measuring system operators.

Tracking Auto Focus (TAF)

AF principle	Objective coaxial autofocusing (knife edge method)						
Suitable objectives	QV-HR1x	QV-SL1x	QV-HR2.5x	QV-SL2.5x	QV-5x		
Tracking range*2	6.3mm	6.3mm	1mm	1mm	0.25mm		
Tracking range*2	(±3.15mm)	(±3.15mm)	(±0.5 mm)	(±0.5 mm)	(±0.125mm)		
Spot diameter*3	5.2µm	8.0µm	2.1µm	3.1µm	1.5µm		
Laser source	Semiconductor laser (peak wavelength: 690nm)						
Laser power	0.9mW						
Laser safety	Class 2 (JIS C6802:2011, EN/IEC 60825-1:2007)						



^{*3} These are design values.





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